

Notice of References Cited	Application/Control No. 10/651,913		Applicant(s)/Patent Under Reexamination SENG ET AL.	
	Examiner Alexander O. Williams		Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,847,104 B2	01-2005	Huang et al.	257/685
*	B	US-6,528,722 B2	03-2003	Huang et al.	174/528
*	C	US-5,973,393	10-1999	Chia et al.	257/690
*	D	US-2002/0046854 A1	04-2002	HUANG et al.	174/52.1
*	E	US-2001/0013645 A1	08-2001	King et al.	257/678
*	F	US-7,195,957 B2	03-2007	Koon et al.	438/124
*	G	US-2005/0026325 A1	02-2005	Koon et al.	438/107
*	H	US-6,784,525	08-2004	Kuan et al.	257/676
*	I	US-2004/0080031 A1	04-2004	Huang et al.	257/678
*	J	US-2004/0150088 A1	08-2004	Corisis, David J.	257/684
*	K	US-2004/0080031 A1	04-2004	Huang et al.	257/678
*	L	US-2004/0026773 A1	02-2004	Koon et al.	257/692
*	M	US-2002/0046854 A1	04-2002	HUANG et al.	174/52.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001087444 A	09-2001	Lee	Lee	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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